

74ALVC16722

Low Voltage 22-Bit Register with 3.6V Tolerant Inputs and Outputs

General Description

The ALVC16722 low voltage 22-bit register contains twenty-two non-inverting D-type flip-flops with 3-STATE outputs and is intended for bus oriented applications. The design has been optimized for use with JEDEC compliant 200 pin DIMM modules.

The 74ALVC16722 is designed for low voltage (1.65V to 3.6V) V_{CC} applications with I/O capability up to 3.6V.

The 74ALVC16722 is fabricated with an advanced CMOS technology to achieve high speed operation while maintaining low CMOS power dissipation.

Features

- 1.65V to 3.6V V_{CC} supply operation
- 3.6V tolerant inputs and outputs
- t_{PD} (CLK to Q_n)
 - 4.1ns max for 3.0V to 3.6V V_{CC}
 - 5.1ns max for 2.3V to 2.7V V_{CC}
 - 9.2ns max for 1.65V to 1.95V V_{CC}
- Power-off high impedance inputs and outputs
- Supports live insertion/withdrawal (Note 1)
- Meets JEDEC registered module specifications
- Latchup conforms to JEDEC JED78
- ESD performance:
 - Human body model > 2000V
 - Machine model >200V

Note 1: To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pull-up resistor; the minimum value of the resistor is determined by the current sourcing capability of the driver.

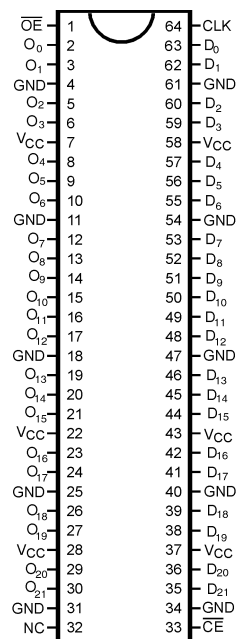
Ordering Code:

Order Number	Package Number	Package Description
74ALVC16722MTD	MTD64	64-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

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Connection Diagram



Pin Descriptions

Pin Names	Description
\overline{OE}	Output Enable Input (Active LOW)
\overline{CE}	Clock Enable Input (Active Low)
CLK	Clock Input
$D_0 - D_{21}$	Data Inputs
$O_0 - O_{21}$	3-STATE Outputs

Truth Table

CLK	\overline{CE}	\overline{OE}	D_n	O_n
X	X	H	X	Z
X	H	L	X	O_n
↑	L	L	L	L
↑	L	L	H	H
L or H	L	L	X	O_n

H = Logic HIGH

L = Logic LOW

X = Don't Care, but not floating

Z = High Impedance

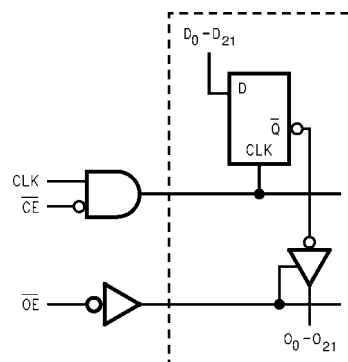
 O_n = Previous O_n before LOW-to-HIGH Clock Transition

↑ = LOW-to-HIGH Clock Transition

Functional Description

The ALVC16722 contains twenty-two D-type flip-flops with 3-STATE standard outputs. The twenty-two flip-flops will store the state of their individual D-type inputs that meet the setup and hold time requirements on the LOW-HIGH Clock (CLK) transition, when the Clock-Enable (\overline{CE}) is LOW. The 3-STATE standard outputs are controlled by the Output-Enable (\overline{OE}). When \overline{OE} is HIGH, the standard outputs are in high impedance mode but this does not interfere with entering new data into the flip-flops.

Logic Diagram



Absolute Maximum Ratings(Note 2)

Supply Voltage (V_{CC})	-0.5V to +4.6V
DC Input Voltage (V_I)	-0.5V to 4.6V
Output Voltage (V_O) (Note 3)	-0.5V to V_{CC} +0.5V
DC Input Diode Current (I_{IK})	
$V_I < 0V$	-50 mA
DC Output Diode Current (I_{OK})	
$V_O < 0V$	-50 mA
DC Output Source/Sink Current (I_{OH}/I_{OL})	± 50 mA
DC V_{CC} or GND Current per Supply Pin (I_{CC} or GND)	± 100 mA
Storage Temperature Range (T_{STG})	-65°C to +150°C

Recommended Operating Conditions (Note 4)

Power Supply	
Operating	1.65V to 3.6V
Input Voltage (V_I)	0V to V_{CC}
Output Voltage (V_O)	0V to V_{CC}
Free Air Operating Temperature (T_A)	-40°C to +85°C
Minimum Input Edge Rate ($\Delta t/\Delta V$)	
$V_{IN} = 0.8V$ to $2.0V$, $V_{CC} = 3.0V$	10 ns/V

Note 2: The Absolute Maximum Ratings are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the Absolute Maximum Ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 3: I_O Absolute Maximum Rating must be observed.

Note 4: Floating or unused inputs must be held HIGH or LOW.

DC Electrical Characteristics

Symbol	Parameter	Conditions	V_{CC} (V)	Min	Max	Units
V_{IH}	HIGH Level Input Voltage		1.65 - 1.95 2.3 - 2.7 2.7 - 3.6	$0.65 \times V_{CC}$ 1.7 2.0		V
V_{IL}	LOW Level Input Voltage		1.65 - 1.95 2.3 - 2.7 2.7 - 3.6		$0.35 \times V_{CC}$ 0.7 0.8	V
V_{OH}	HIGH Level Output Voltage	$I_{OH} = -100 \mu A$	1.65 - 3.6	$V_{CC} - 0.2$		V
		$I_{OH} = -4 \text{ mA}$	1.65	1.2		
		$I_{OH} = -6 \text{ mA}$	2.3	2		
		$I_{OH} = -12 \text{ mA}$	2.3 2.7 3.0	1.7 2.2 2.4		
		$I_{OH} = -24 \text{ mA}$	3.0	2		
V_{OL}	LOW Level Output Voltage	$I_{OL} = 100 \mu A$	1.65 - 3.6		0.2	V
		$I_{OL} = 4 \text{ mA}$	1.65		0.45	
		$I_{OL} = 6 \text{ mA}$	2.3		0.4	
		$I_{OL} = 12 \text{ mA}$	2.3 2.7		0.7 0.4	
		$I_{OL} = 24 \text{ mA}$	3		0.55	
I_I	Input Leakage Current	$0 \leq V_I \leq 3.6V$	3.6		± 5.0	μA
I_{OZ}	3-STATE Output Leakage	$0 \leq V_O \leq 3.6V$	3.6		± 10	μA
I_{CC}	Quiescent Supply Current	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6		40	μA
ΔI_{CC}	Increase in I_{CC} per Input	$V_{IH} = V_{CC} - 0.6V$	3 - 3.6		750	μA

AC Electrical Characteristics

Symbol	Parameter	T _A = −40°C to +85°C, R _L = 500Ω								Units
		C _L = 50 pF				C _L = 30 pF				
		V _{CC} = 3.3V ± 0.3V		V _{CC} = 2.7V		V _{CC} = 2.5V ± 0.2V		V _{CC} = 1.8V ± 0.15V		
		Min	Max	Min	Max	Min	Max	Min	Max	
f _{MAX}	Maximum Clock Frequency	250		200		200		100		ns
t _{PHL} , t _{PLH}	Propagation Delay CLK to Bus	1.3	4.1	2.0	5.1	1.5	4.6	2.0	9.2	ns
t _{PZL} , t _{PZH}	Output Enable Time	1.1	4.0	1.3	5.0	0.8	4.5	1.5	9.0	ns
t _{PLZ} , t _{PHZ}	Output Disable Time	1.1	3.7	1.3	4.7	0.8	4.2	1.5	7.6	ns
t _W	Pulse Width	1.5		1.5		1.5		4.0		ns
t _S	Setup Time	2.0		2.0		2.0		3.0		ns
t _H	Hold Time	0.0		0.0		0.0		0.5		ns

Capacitance

Symbol	Parameter	Conditions	$T_A = +25^\circ\text{C}$		Units
			V_{CC}	Typical	
C_{IN}	Input Capacitance	$V_I = 0V \text{ or } V_{CC}$	3.3	3.5	pF
C_{OUT}	Output Capacitance	$V_I = 0V \text{ or } V_{CC}$	3.3	5.5	pF
C_{PD}	Power Dissipation Capacitance	Outputs Enabled $f = 10\text{ MHz}, C_L = 50\text{ pF}$	3.3	13	pF
			2.5	13	

$I_{OUT} - V_{OUT}$ Characteristics

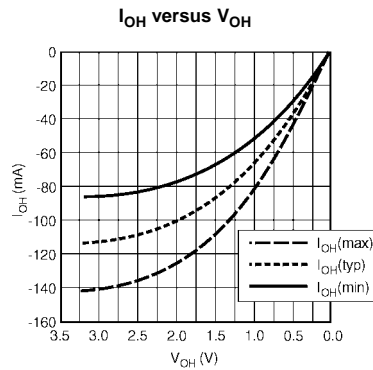


FIGURE 1. Characteristics for
Output - Pull Up Driver

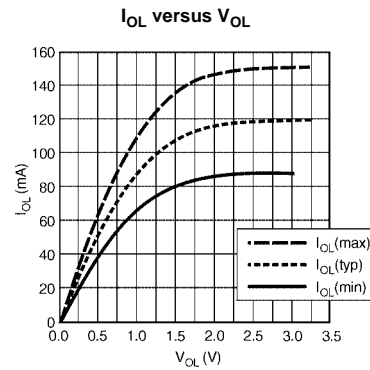


FIGURE 2. Characteristics for
Output - Pull Down Driver

AC Loading and Waveforms

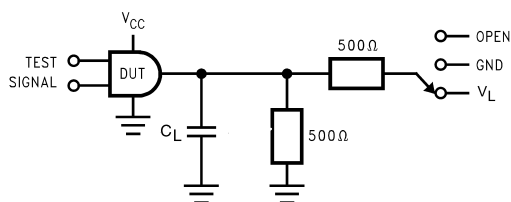


FIGURE 3. AC Test Circuit

TABLE 1. Values for Figure 1

TEST	SWITCH
t_{PLH} , t_{PHL}	Open
t_{PZL} , t_{PLZ}	V_L
t_{PZH} , t_{PHZ}	GND

TABLE 2. Variable Matrix
(Input Characteristics: $f = 1\text{MHz}$; $t_r = t_f = 2\text{ns}$; $Z_0 = 50\Omega$)

Symbol	V_{CC}			
	$3.3V \pm 0.3V$	2.7V	$2.5V \pm 0.2V$	$1.8V \pm 0.15V$
V_{mi}	1.5V	1.5V	$V_{CC}/2$	$V_{CC}/2$
V_{mo}	1.5V	1.5V	$V_{CC}/2$	$V_{CC}/2$
V_X	$V_{OL} + 0.3V$	$V_{OL} + 0.3V$	$V_{OL} + 0.15V$	$V_{OL} + 0.15V$
V_Y	$V_{OH} - 0.3V$	$V_{OH} - 0.3V$	$V_{OH} - 0.15V$	$V_{OH} - 0.15V$
V_L	6V	6V	$V_{CC} \times 2$	$V_{CC} \times 2$

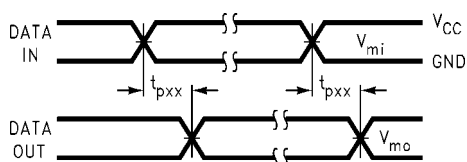


FIGURE 4. Waveform for Inverting and Non-inverting Functions
 $t_r = t_f \leq 2.0\text{ns}$, 10% to 90%

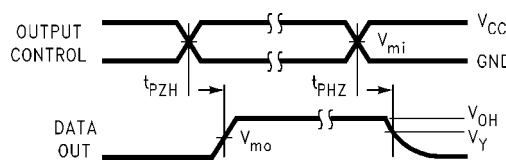


FIGURE 5. 3-STATE Output High Enable and Disable Times for Low Voltage Logic
 $t_r = t_f \leq 2.0\text{ns}$, 10% to 90%

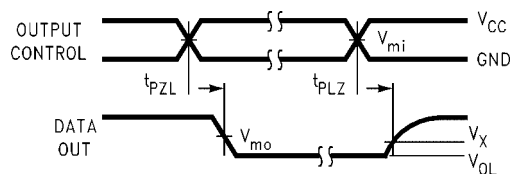
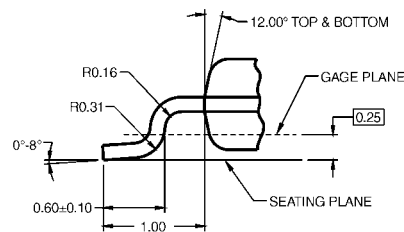


FIGURE 6. 3-STATE Output Low Enable and Disable Times for Low Voltage Logic
 $t_r = t_f \leq 2.0\text{ns}$, 10% to 90%



DETAIL A

- A. CONFORMS TO JEDEC REGISTRATION MO-153, VARIATION EF, REF NOTE 6, DATE 7/93.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

MTD64REVB

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